

1.Description

This N-Channel logic level enhancement mode field effect transistor is produced using Fairchild's proprietary, high cell density, DMOS technology. This very high density process is especially tailored to minimize on-state resistance.

2.Features

- $V_{DS(V)}=20V$
- $I_D=6A$
- $R_{DS(ON)}<28m\Omega(V_{GS}=4.5V)$
- $R_{DS(ON)}<42m\Omega(V_{GS}=2.5V)$
- $R_{DS(ON)}<50m\Omega(V_{GS}=1.8V)$

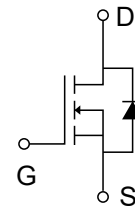
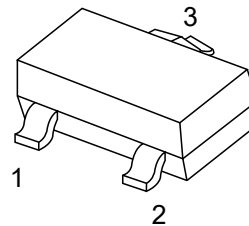
3.Applications

- DC/DC Converters
- Load Switch for Portable Applications

4.Pinning information

Pin	Symbol	Description
1	G	GATE
2	S	SOURCE
3	D	DRAIN

SOT-23



5.Maximum ratings ($T_A=25^{\circ}C$ unless otherwise noted)

Parameter		Symbol	Maximum	Units
Drain-Source Voltage		V_{DS}	20	V
Gate-Source Voltage		V_{GS}	± 12	
Continuous Drain Current ($T_J = 150^{\circ}C$)	$T_C=25^{\circ}C$	I_D	6 ^a	A
	$T_C=70^{\circ}C$		5.1	
	$T_A=25^{\circ}C$		5 ^{b,c}	
	$T_A=70^{\circ}C$		4 ^{b,c}	
Pulsed Drain Current		I_{DM}	20	
Continuous Source-Drain Diode Current	$T_C=25^{\circ}C$	I_S	1.75	
	$T_A=25^{\circ}C$		1.04 ^{b,c}	



Maximum Power Dissipation	$T_C=25^{\circ}\text{C}$	P_D	2.1	W
	$T_C=70^{\circ}\text{C}$		1.3	
	$T_A=25^{\circ}\text{C}$		$1.25^{b,c}$	
	$T_A=70^{\circ}\text{C}$		$0.8^{b,c}$	
Operating Junction and Storage Temperature Range		T_J, T_{STG}	-55 to 150	$^{\circ}\text{C}$
Soldering Recommendations (Peak Temperature)			260	$^{\circ}\text{C}$

6.Thermal resistance rating

Parameter		Symbol	Typ	Max	Units
Maximum Junction-to-Ambient ^{b,d}	$t \leq 5\text{s}$	R_{thJA}	80	100	$^{\circ}\text{C/W}$
Maximum Junction-to-Foot (Drain)	Steady-State	R_{thJF}	40	60	$^{\circ}\text{C/W}$

- Notes:
- a. Package limited
 - b. Surface Mounted on 1" x 1" FR4 board.
 - c. $t = 5\text{ s}$.
 - d. Maximum under steady state conditions is $125\text{ }^{\circ}\text{C/W}$.
 - e. Based on $TC = 25\text{ }^{\circ}\text{C}$.



7. Electrical Characteristics ($T_J=25^{\circ}\text{C}$ unless otherwise noted)

Parameter	Symbol	Conditions	Min	Typ	Max	Units
Static						
Drain-Source Breakdown Voltage	V_{DS}	$V_{DS}=0\text{V}, I_D=250\mu\text{A}$	20			V
V_{DS} Temperature Coefficient	$\Delta V_{DS}/T_J$	$I_D=250\mu\text{A}$		25		mV/ $^{\circ}\text{C}$
$V_{GS(th)}$ Temperature Coefficient	$\Delta V_{GS(th)}/T_J$			-2.6		
Gate-Source Threshold Voltage	$V_{GS(th)}$	$V_{DS}=V_{GS}, I_D=250\mu\text{A}$	0.45		1	V
Gate-Source Leakage	I_{GSS}	$V_{DS}=0\text{V}, V_{GS}=\pm 8\text{V}$			± 100	nA
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS}=20\text{V}, V_{GS}=0\text{V}$			1	μA
		$V_{DS}=20\text{V}, V_{GS}=0\text{V}, T_J=70^{\circ}\text{C}$			10	
On-State Drain Current ^a	$I_{D(ON)}$	$V_{DS}\leq 5\text{V}, V_{GS}=4.5\text{V}$	20			A
Drain-Source On-State Resistance ^a	$R_{DS(ON)}$	$V_{GS}=4.5\text{V}, I_D=5\text{A}$		28		m Ω
		$V_{GS}=2.5\text{V}, I_D=4.7\text{A}$		42		
		$V_{DS}=1.8\text{V}, I_D=4.3\text{A}$		50		
Forward Transconductance ^a	g_{FS}	$V_{DS}=10\text{V}, I_D=5\text{A}$		24		S
Dynamic^b						
Input Capacitance	C_{iss}	$V_{DS}=10\text{V}, V_{GS}=0\text{V}, f=1\text{MHz}$		865		pF
Output Capacitance	C_{oss}			105		
Reverse Transfer Capacitance	C_{rss}			55		
Total Gate Charge	Q_g	$V_{DS}=10\text{V}, V_{GS}=5\text{V}$ $I_D=5\text{A}$		12	18	nC
				8.8	14	
Gate Source Charge	Q_{gs}	$V_{DS}=10\text{V}, V_{GS}=4.5\text{V}$ $I_D=5\text{A}$		1.1		
Gate Drain Charge	Q_{gd}			0.7		
Gate Resistance	R_g	$f=1\text{MHz}$	0.5	2.4	4.8	Ω
Turn-On DelayTime	$t_{D(on)}$	$V_{DD}=10\text{V}, R_L=2.2\Omega$ $I_D\leq 4\text{A}, V_{GEN}=4.5\text{V}$ $R_g=1\Omega$		8	16	ns
Rise Time	t_r			17	26	
Turn-Off DelayTime	$t_{D(off)}$			31	47	
Fall Time	t_f			8	16	



Turn-On Delay Time	$t_{D(on)}$	$V_{DD}=10V, R_L=2.2\Omega$ $I_D=4A, V_{GEN}=5V$ $R_g=1\Omega$		5	10	ns
Rise Time	t_r			13	20	ns
Turn-Off Delay Time	$t_{D(off)}$			21	32	ns
Fall Time	t_f			6	12	ns
Drain-Source Body Diode Characteristics						
Continuous Source-Drain Diode Current	I_S	$T_C=25^{\circ}C$			1.75	A
Pulse Diode Forward Current ^a	I_{SM}				20	A
Body Diode Voltage	V_{SD}	$I_S=4A, V_{GS}=0V$		0.75	1.2	V
Body Diode Reverse Recovery Time	t_{rr}	$I_F=4A, dI/dt=100A/\mu s$ $T_J=25^{\circ}C$		12	20	ns
Body Diode Reverse Recovery Charge	Q_{rr}			5	10	nC
Reverse Recovery Fall Time	t_a			7		ns
Reverse Recovery Rise Time	t_b			5		ns

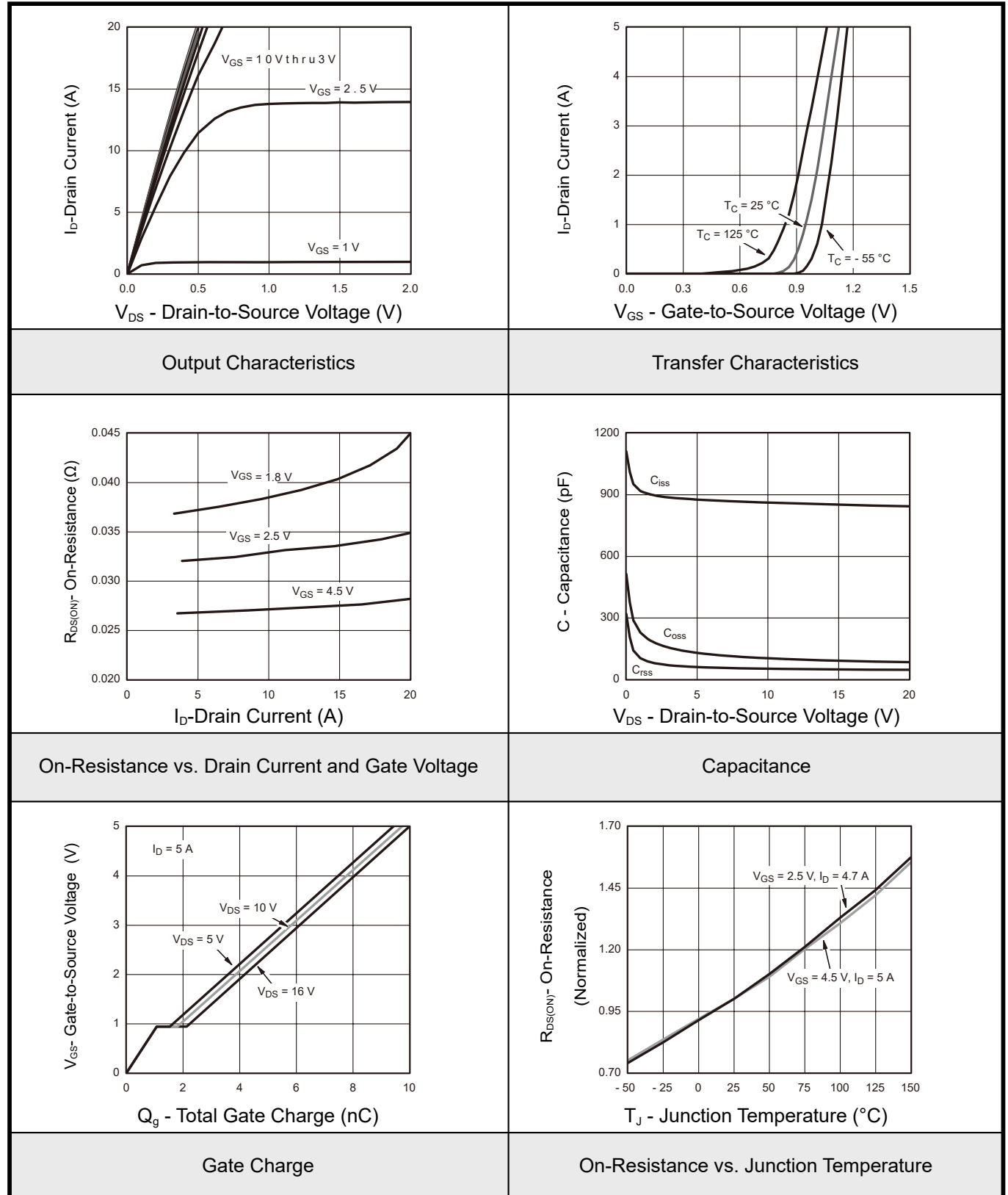
Notes:

a. Pulse test; pulse width $\leq 300 \mu s$, duty cycle $\leq 2\%$.

b. Guaranteed by design, not subject to production testing.

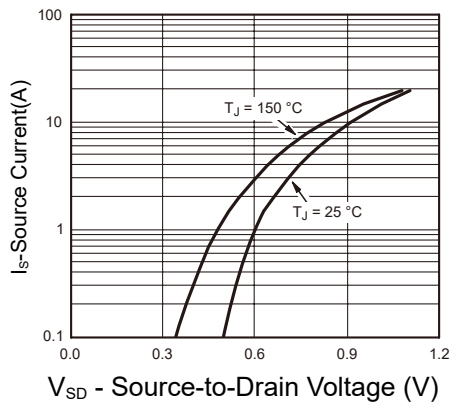


8.1 Typical Characteristics

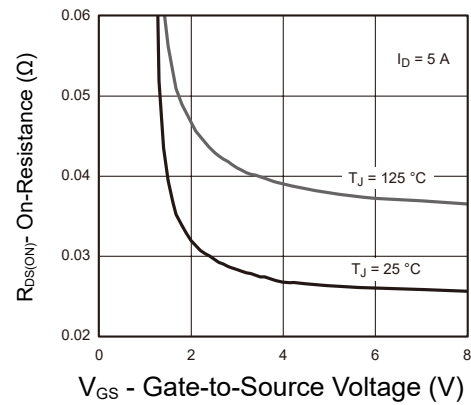




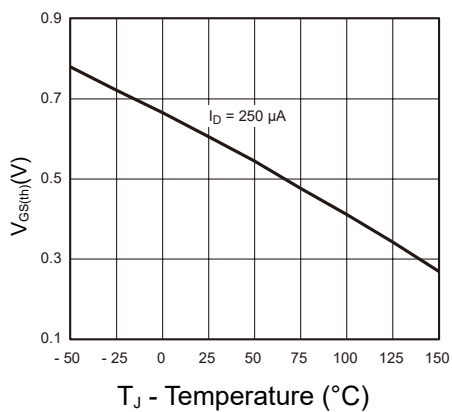
8.2 Typical Characteristics



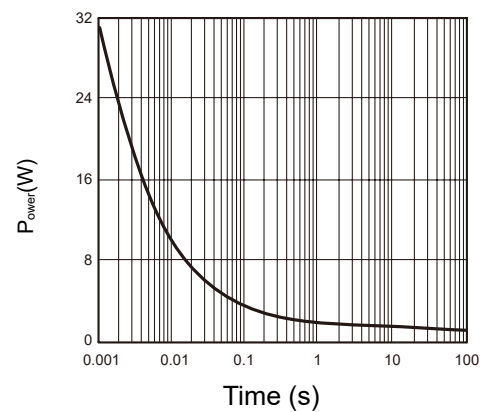
Source-Drain Diode Forward Voltage



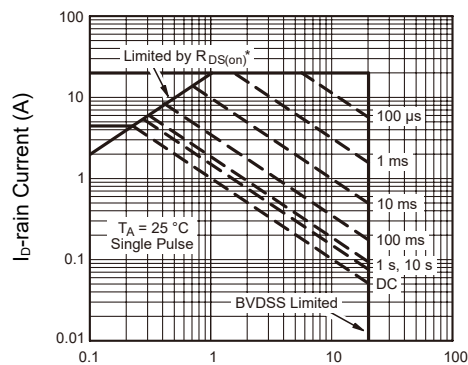
On-Resistance vs. Gate-to-Source Voltage



Threshold Voltage



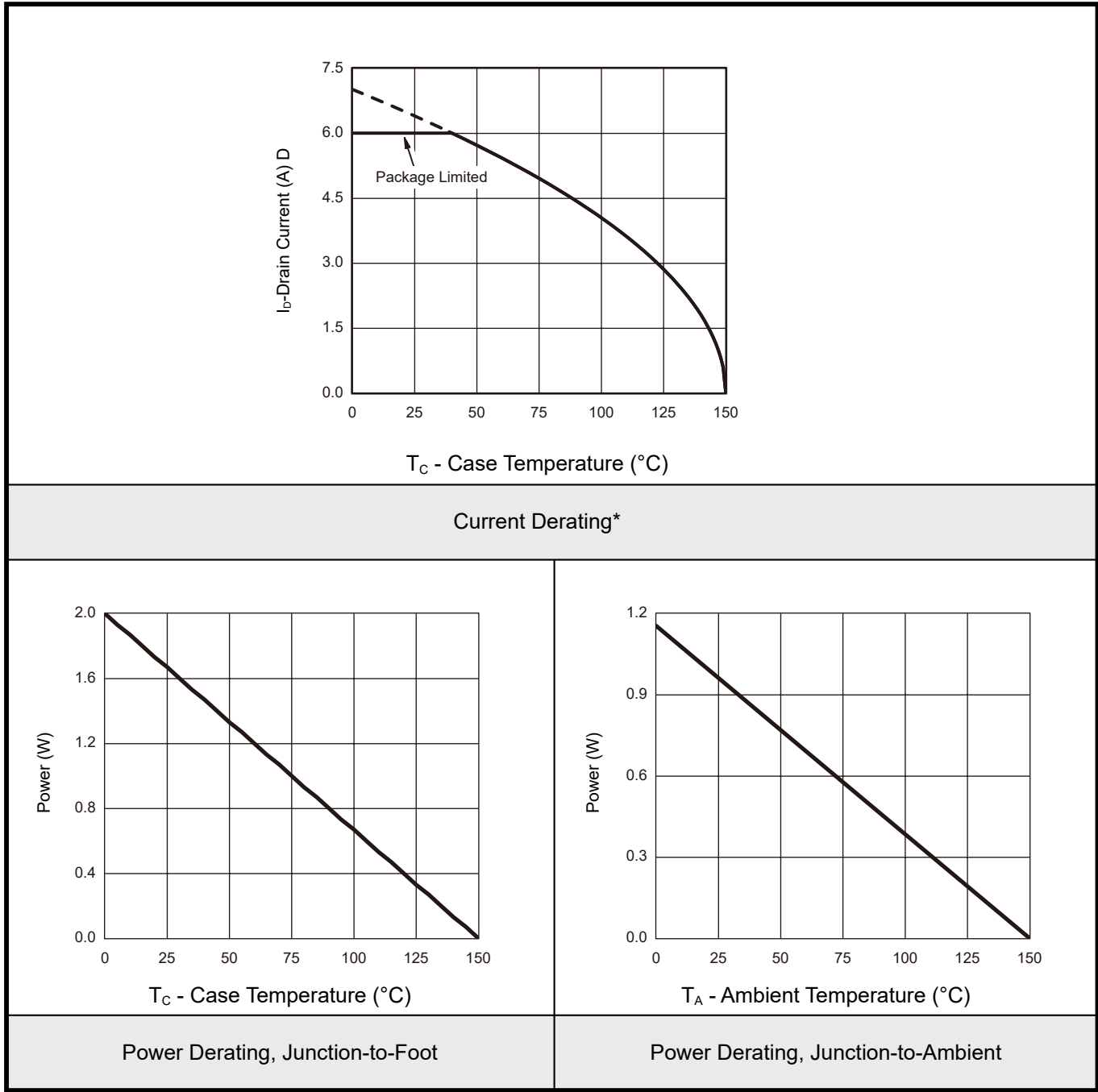
Single Pulse Power, Junction-to-Ambient



Safe Operating Area, Junction-to-Ambient



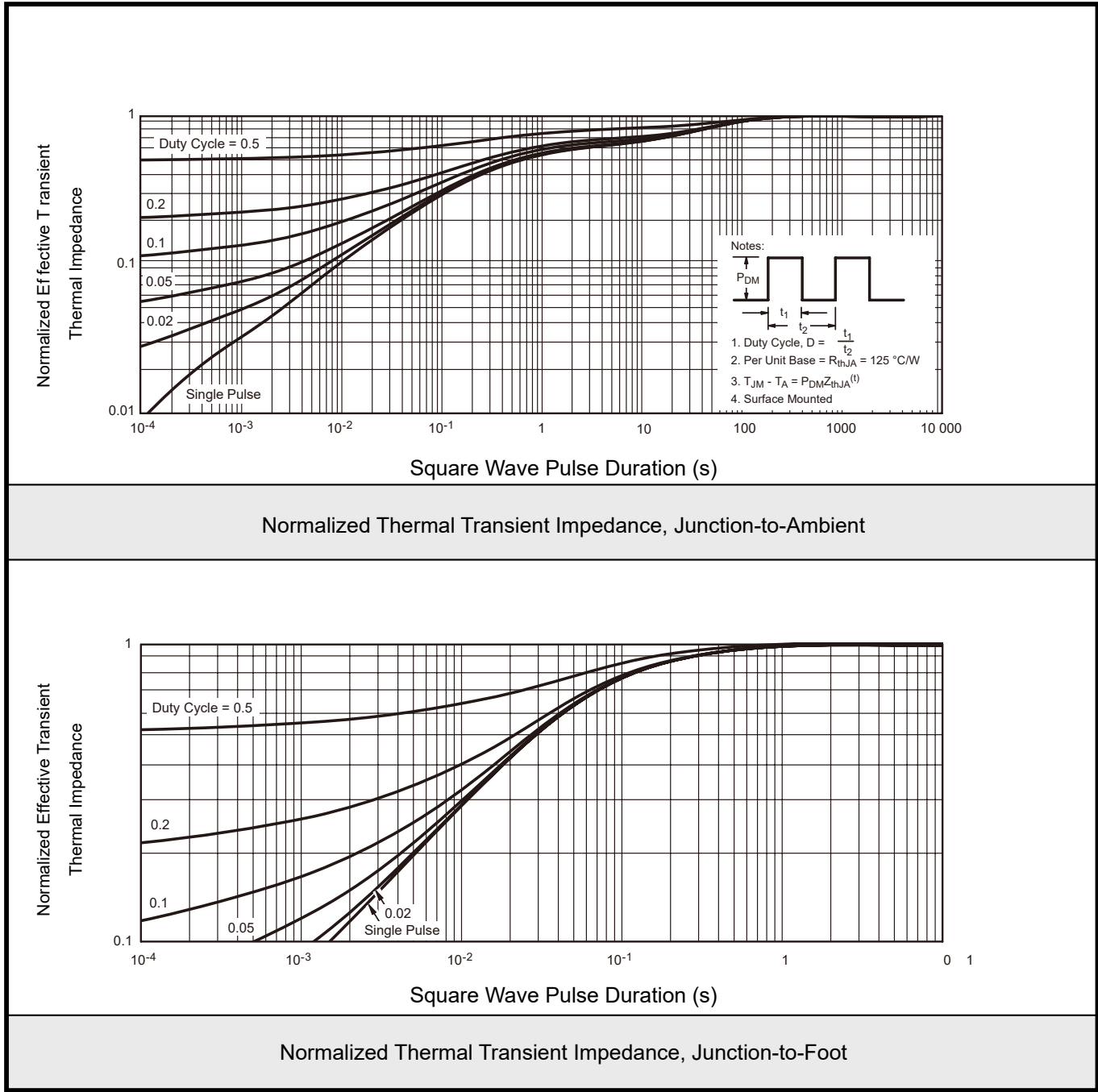
8.3Typical Characteristics



* The power dissipation P_D is based on $T_{J(max)} = 150\text{ }^{\circ}\text{C}$, using junction-to-case thermal resistance, and is more useful in settling the upperdissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

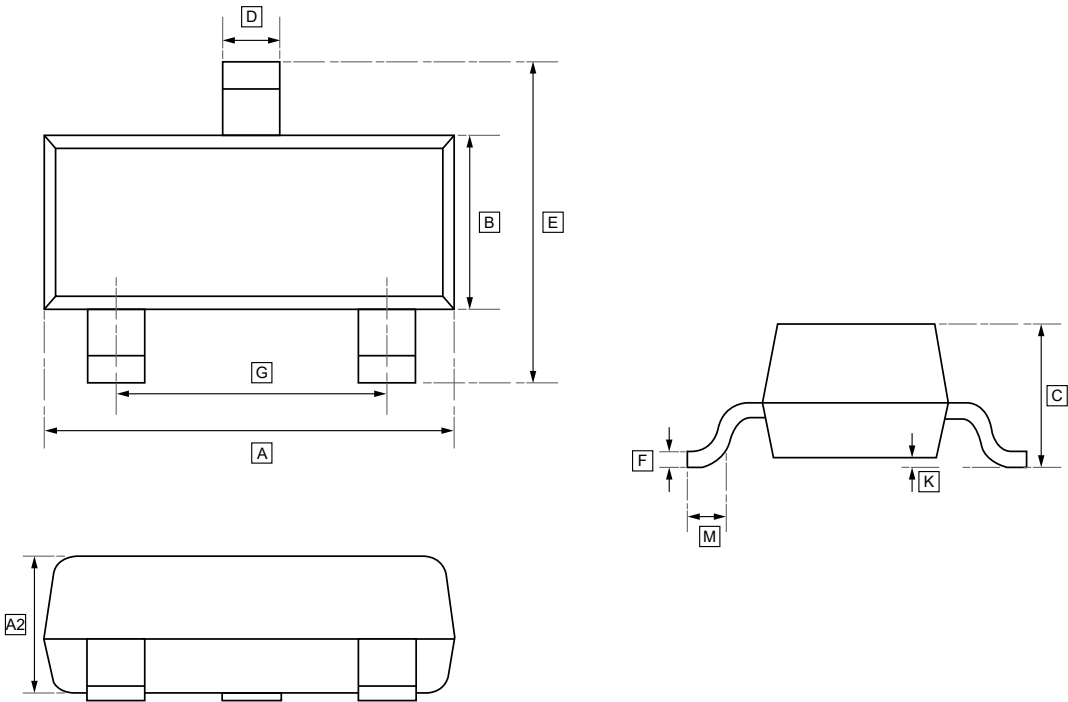


8.4Typical Characterisitics





9.SOT-23 Package Outline Dimensions

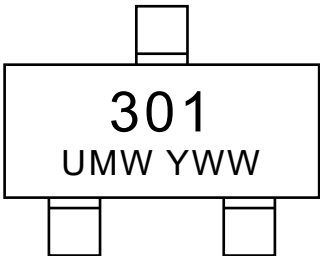


DIMENSIONS (mm are the original dimensions)

Symbol	A	B	C	D	E	G	K	M	A2	F
Min	2.85	1.20	0.90	0.40	2.25	1.80	0.00	0.30	0.95	0.095
Max	3.04	1.40	1.10	0.50	2.55	2.00	0.10	-	1.05	0.115



10.Ordering information



YWW: Batch Code

Order Code	Package	Base QTY	Delivery Mode
UMW FDV301N	SOT-23	3000	Tape and reel



11.Disclaimer

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